Notice of References Cited Application/Control No. 10/519,837 Examiner M. Wilczewski Applicant(s)/Patent Under Reexamination SADAMITSU ET AL. Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,544,656	04-2003	Abe et al.	428/446
*	В	US-5,502,331	03-1996	Inoue et al.	257/617
*	С	US-6,905,771	06-2005	Ono et al.	428/446
*	D	US-6,277,201	08-2001	Nishikawa, Tomohisa	118/726
*	Ε	US-2003/0192469	10-2003	Libbert et al.	117/2
*	F	US-2005/0103256	05-2005	Sadamitsu et al.	117/020
*	G	US-2006/0266278	11-2006	Ono et al.	117/019
*	Н	US-2007/0066033	03-2007	Kurita et al.	438/473
*	1	US-2007/0105279	05-2007	Falster et al.	438/113
	J	US-			
	κ	US-			
	Ļ	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country .	Name	Classification
	Z					
	0					
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
4.5	v						
	w						
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.